Author's response to reviews

Title: A Six-generation Chinese Family in Haplogroup B4C1C Exhibits High Penetrance of 1555A>G-induced Hearing Loss

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Dear editor:
Enclosed for your consideration is an original research article, entitled A Six-generation Chinese Family in Haplogroup B4C1C Exhibits High Penetrance of A1555G-induced Hearing Loss. All authors of this research paper have directly participated in the planning, execution, or analysis of this study.
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We believe the paper may be of particular interest to the readers of your journal. Correspondence and phone calls about the paper should be directed to Zhengmin Wang and Huawei Li. They can be communicated at the following address, fax, phone and E-mail address:

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